



FINAL DRAFT International Standard

ISO/FDIS 5490

Steel — Rating and classifying nonmetallic inclusions using the scanning electron microscope

*Acier — Classement et classification des inclusions non
métalliques à l'aide du microscope électronique à balayage*

ISO/TC 17/SC 7

Secretariat: **AFNOR**

Voting begins on:
2025-07-09

Voting terminates on:
2025-09-03

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Published in Switzerland

Contents

Page

Foreword	iv
1 Scope	1
2 Normative references	1
3 Terms and definitions	1
4 Principles	2
5 Equipment and software	4
6 Calibration and inspection of equipment	5
7 Sampling	5
8 Preparation of specimens	5
9 Procedure	5
10 Rating and statistical analysis of inclusions	7
10.1 Rating method.....	7
10.1.1 Morphology rating method.....	7
10.1.2 Chemistry rating method.....	8
10.2 Statistical analysis method.....	9
11 Test report	10
Annex A (informative) Typical acquisition analysis rules to be set for SEM analysis	11
Annex B (informative) Example of test results using morphology rating method	12
Annex C (informative) Examples of test results using statistical analysis method	14
Bibliography	19

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This document was prepared by Technical Committee ISO/TC 17, *Steel*, Subcommittee SC 7, *Methods of testing (other than mechanical tests and chemical analysis)*.

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